Application/Control No. Applicant(s)/Patent Under Notic of R ferenc s Cited 09/886,559 Reexamination CONRAD ET AL. Examiner Art Unit Hae M Hyeon Pag 1 of 1 2839 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	U.S. PATENT DOCUMENTS	 1
\bot	Α	US-	191191-1117	Name	Classification
\perp	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
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*		Document Number	FOREIGN PATENT DOCUMENTS			
{		Country Code-Number-Kind Code	Date MM-YYYY	Country		
4	N	JP 01138517 A	05-1989	Japan	Name	Classification
	0	JP 01138518 A	05-1989		TSUNODA, TATSUYA	G02B 06/44
	Р	JP 01200311 A	 	Japan	TSUNODA, TATSUYA	
1	Q	JP 01251005 A	08-1989	Japan	FUCHIGAMI et al.	G02B 06/44
\dagger			10-1989	Japan	ARAKI et al.	G02B 06/44
╀		JP 02282709 A	11-1990	Japan		G02B 06/44
Ļ	s				TAKAHASHI et al.	G02B 06/44
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US. Pat	ent and	rademark Office